

November 1992 Revised March 1999

74VHC245 Octal Bidirectional Transceiver with 3-STATE Outputs

General Description

The VHC245 is an advanced high speed CMOS octal bus transceiver fabricated with silicon gate CMOS technology. It achieves high speed operation similar to equivalent Bipolar Schottky TTL while maintaining the CMOS low power dissipation. The VHC245 is intended for bidirectional asynchronous communication between data busses. The direction of data transmission is determined by the level of the T/\overline{R} input. The enable input can be used to disable the device so that the busses are effectively isolated. All inputs are equipped with protection circuits against static discharge.

Features

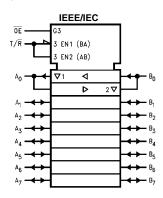
- High Speed: $t_{PD} = 4.0$ ns (typ) at $V_{CC} = 5V$
- High Noise Immunity: V_{NIH} = V_{NIL} = 28% V_{CC} (Min)
- Power Down Protection is provided on all inputs
- Low Noise: V_{OLP} = 0.9V (typ)
- Low Power Dissipation: $I_{CC} = 4 \mu A \text{ (Max) } @ T_A = 25 ^{\circ} \text{C}$
- Pin and Function Compatible with 74HC245

Ordering Code:

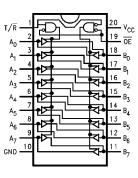
Order Number	Package Number	Package Description
74VHC245M	M20B	20-Lead Small Outline Integrated Package (SOIC), JEDEC MS-013, 0.300" Wide
74VHC245SJ	M20D	20-Lead Small Outline Package (SOP), EIAJ TYPE II, 5.3mm Wide
74VHC245MTC	MTC20	20-Lead Thin Shrink Small Outline Package (TSSOP), JEDEC MO-153, 4.4mm Wide
74VHC245N	N20A	20-Lead Plastic Dual-In-Line Package (PDIP), JEDEC MS-001, 0.300" Wide

Surface mount packages are also available on Tape and Reel. Specify by appending the suffix letter "X" to the ordering code.

Logic Symbol



Connection Diagram



Pin Description

Pin	Description						
Names							
OE	Output Enable Input						
T/R	Transmit/Receive Input						
A ₀ -A ₇	Side A Inputs or 3-STATE Outputs						
B ₀ -B ₇	Side B Inputs or 3-STATE Outputs						

Truth Table

Inputs		Outputs
OE T/R		
L	L	Bus B Data to Bus A
L	Н	Bus A Data to Bus B
Н	Χ	HIGH-Z State

 $\label{eq:Heaviside} \begin{array}{lll} H = HIGH\ Voltage\ Level & L = LOW\ Voltage\ Level & X = Immaterial \\ Any\ unused\ bus\ terminals\ during\ HIGH-Z\ State\ must\ be\ held\ HIGH\ or\ LOW. \end{array}$

Absolute Maximum Ratings(Note 1)

-0.5V to +7.0V Supply Voltage (V_{CC}) DC Input Voltage (V_{IN}) $(T/\overline{R}, \overline{OE})$ -0.5V to 7.0V DC Output Voltage (V_{OUT}) -0.5V to $V_{CC} + 0.5V$ Input Diode Current (I_{IK}) (T/R, OE) -20 mA Output Diode Current (I_{OK}) ±20 mA DC Output Current (I_{OUT}) ±25 mA DC V_{CC} /GND Current (I_{CC}) ±75 mA Storage Temperature (T_{STG}) $-65^{\circ}C$ to $+150^{\circ}C$

Lead Temperature (T_L)

(Soldering, 10 seconds)

Recommended Operating Conditions (Note 2)

Input Rise and Fall Time (t_r, t_f)

$$\begin{split} V_{CC} = 3.3 \text{V} \pm 0.3 \text{V} & 0 \sim 100 \text{ ns/V} \\ V_{CC} = 5.0 \text{V} \pm 0.5 \text{V} & 0 \sim 20 \text{ ns/V} \end{split}$$

Note 1: Absolute Maximum Ratings are values beyond which the device may be damaged or have its useful life impaired. The databook specifications should be met, without exception, to ensure that the system design is reliable over its power supply, temperature, and output/input loading variables. Fairchild does not recommend operation outside databook specifications

Note 2: Unused inputs or I/O pins must be held HIGH or LOW. They may not float

DC Electrical Characteristics

Symbol	Parameter	V _{CC}	T _A = 25°C			$T_A = -40^{\circ}C \text{ to } +85^{\circ}C$		Units	Conditions	
		(V)	Min	Тур	Max	Min	Max	Units	Conditions	
V _{IH}	HIGH Level	2.0	1.50			1.50		V		
	Input Voltage	3.0 - 5.5	0.7 V _{CC}			0.7 V _{CC}		V		
V _{IL}	LOW Level	2.0			0.50		0.50	V		
	Input Voltage	3.0 – 5.5			$0.3\mathrm{V}_{\mathrm{CC}}$		$0.3 V_{\rm CC}$	V		
V _{OH}	HIGH Level	2.0	1.9	2.0		1.9			$V_{IN} = V_{IH}$ $I_{OH} = -50 \mu A$	
	Output Voltage	3.0	2.9	3.0		2.9		V	or V _{IL}	
		4.5	4.4	4.5		4.4				
		3.0	2.58			2.48		V	$I_{OH} = -4 \text{ mA}$	
		4.5	3.94			3.80		V	$I_{OH} = -8 \text{ mA}$	
V _{OL}	LOW Level	2.0		0.0	0.1		0.1		$V_{IN} = V_{IH}$ $I_{OL} = 50 \mu A$	
	Output Voltage	3.0		0.0	0.1		0.1	V	or V _{IL}	
		4.5		0.0	0.1		0.1			
		3.0			0.36		0.44	V	I _{OL} = 4 mA	
		4.5			0.36		0.44	V	$I_{OL} = 8 \text{ mA}$	
I _{OZ}	3-STATE Output								V _{IN} = V _{CC} or GND	
	Off-State Current	5.5			±0.25		±2.5	μΑ	$V_{OUT} = V_{CC}$ or GND	
									$V_{IN} \overline{OE} = V_{IH} \text{ or } V_{IL}$	
I _{IN}	Input Leakage	0 – 5.5			±0.1		±1.0	μΑ	V _{IN} = 5.5V or GND	
$(T/\overline{R}, \overline{OE})$	Current									
I _{CC}	Quiescent Supply Current	5.5			4.0		40.0	μΑ	V _{IN} = V _{CC} or GND	

260°C

Noise Characteristics

Symbol	Parameter	V _{CC} (V)	T _A =	= 25°C	Units	Conditions	
- Cy			Тур	Limits		oonamone .	
V _{OLP}	Quiet Output Maximum	5.0	0.9	1.2	V	C _L = 50 pF	
(Note 3)	Dynamic V _{OL}						
V _{OLV}	Quiet Output Minimum	5.0	-0.9	-1.2	V	C _L = 50 pF	
(Note 3)	Dynamic V _{OL}						
V_{IHD}	Minimum HIGH Level	5.0		3.5	V	C _L = 50 pF	
(Note 3)	Dynamic Input Voltage						
V_{ILD}	Maximum LOW Level	5.0		1.5	V	C _L = 50 pF	
(Note 3)	Dynamic Input Voltage						

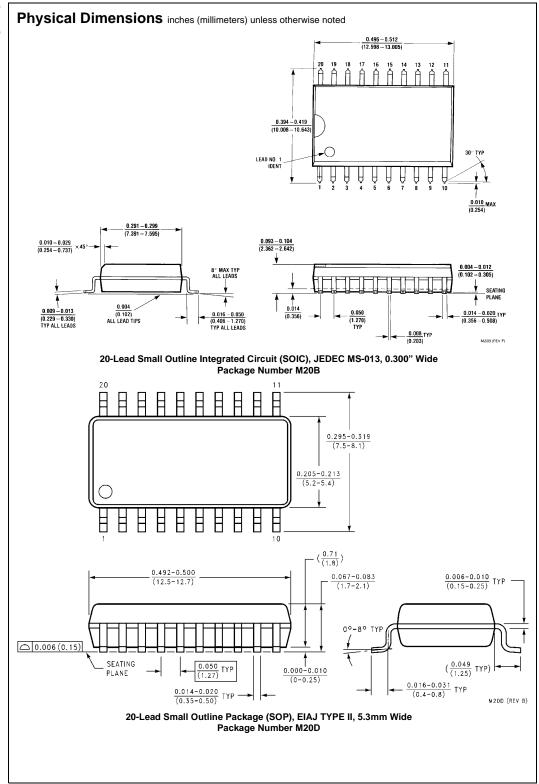
Note 3: Parameter guaranteed by design.

AC Electrical Characteristics

Symbol	Parameter	V _{CC}	$T_A = 25^{\circ}C$			T _A = -40°	C to +85°C	Units	Conditions	
		(V)	Min	Тур	Max	Min	Max	Ullits	Conc	
t _{PLH}	Propagation Delay	3.3 ± 0.3		5.8	8.4	1.0	10.0			$C_L = 15 pF$
t _{PHL}	Time			8.3	11.9	1.0	13.5	ns		$C_{L} = 50 \text{ pF}$
		5.0 ± 0.5		4.0	5.5	1.0	6.5	ns		C _L = 15 pF
				5.5	7.5	1.0	8.5	115		$C_L = 50 pF$
t _{PZL}	3-STATE Output	3.3 ± 0.3		8.5	13.2	1.0	15.5	ns	$R_L = 1 k\Omega$	$C_{L} = 15 \text{ pF}$
t_{PZH}	Enable Time			11.0	16.7	1.0	19.0	115		$C_L = 50 pF$
		5.0 ± 0.5		5.8	8.5	1.0	10.0	ns	1	$C_{L} = 15 \text{ pF}$
				7.3	10.6	1.0	12.0	115		$C_L = 50 pF$
t _{PLZ}	3-STATE Output	3.3 ± 0.3		11.5	15.8	1.0	18.0	ns	$R_L = 1 k\Omega$	$C_L = 50 pF$
t_{PHZ}	Disable Time	5.0 ± 0.5		7.0	9.7	1.0	11.0	115		$C_{L} = 50 \text{ pF}$
t _{OSLH}	Output to Output	3.3 ± 0.3			1.5		1.5	ns	(Note 4)	$C_{L} = 50 \text{ pF}$
toshl	Skew	5.0 ± 0.5			1.0		1.0	115		$C_L = 50 pF$
C _{IN}	Input Capacitance			4	10		10	pF	V _{CC} = Open	
$(T/R, \overline{OE})$										
C _{I/O}	Output Capacitance			8				pF	V _{CC} = 5.0V	
C _{PD}	Power Dissipation			21				pF	(Note 5)	
	Capacitance									

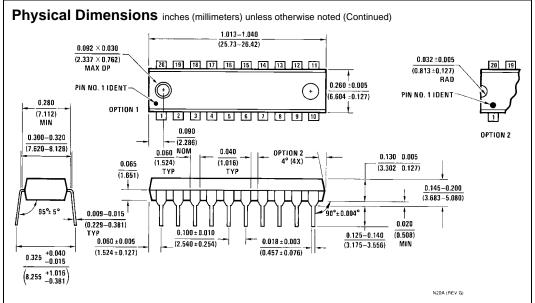
 $\textbf{Note 4:} \ Parameter \ guaranteed \ by \ design. \ t_{OSLH} = |t_{PLH \ max} - t_{PLH \ min}|; \ t_{OSHL} = |t_{PHL \ max} - t_{PHL \ min}|$

Note 5: C_{PD} is defined as the value of the internal equivalent capacitance which is calculated from the operating current consumption without load. Average operating current can be obtained by the equation: I_{CC} (opr.) = C_{PD} * V_{CC} * f_{IN} + I_{CC} /8 (per Bit).



Physical Dimensions inches (millimeters) unless otherwise noted (Continued) 6.5±0.1 -0.20 7.72 4.16 6,4 4.4±0.1 -B-3.2 0.42 0.65 PIN #1 IDENT. -LAND PATTERN RECOMMENDATION O.1 C SEE DETAIL A -0.90+0.15 -0.10 0.09-0.20 0.1±0.05 0.65 0.19-0.30 | \$\P\$ | 0.10\P\$ | A B\$ | C\$ | . -12.00° R0.09min GAGE PLANE DIMENSIONS ARE IN MILLIMETERS NOTES: 0.25 SEATING PLANE A. CONFORMS TO JEDEC REGISTRATION MD-153, VARIATION AC, REF NOTE 6, DATE $7/93.\,$ -0.6±0.1--R0.09mln **−**1.00 B. DIMENSIONS ARE IN MILLIMETERS. C. DIMENSIONS ARE EXCLUSIVE OF BURRS, MOLDS FLASH, AND TIE BAR EXTRUSIONS. DETAIL A D. DIMENSIONS AND TOLERANCES PER ANSI Y14.5M, 1982.

20-Lead Thin Shrink Small Outline Package (TSSOP), JEDEC MO-153, 4.4mm Wide Package Number MTC20



20-Lead Plastic Dual-In-Line Package (PDIP), JEDEC MS-001, 0.300" Wide Package Number N20A

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